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M	US-2003/0089687	05-	2003	Maki					
M	US-2002/0006678	01-	2002	Inazumachi, et al.					
dis	US-5,688,331	11-	1997	Aruga, et al.					
]	US-					 			
	US-					<u> </u>	<u></u>	<u> </u>	
]	FOREIG	N PATENT DOCUME	ENTS		τ		
	Document Number		Date M-YYYY	Country	Class	Sub- class	Translation Yes No		
			<u> </u>				Yes	X	
<u> </u>	2001-287982		-2001	Japan		 		<u> </u>	
<u> </u>	2003-152064		-2003	Japan		 		X	
dy_	7-153706		-1995	Japan		 	 	X	
fn.	Љ-4-3001136		-1992	Japan		<u> </u>	<u> </u>	х	
Dry.	JP-6-151044		-1994	Japan		-		X	
m-	7 1		-1994	Japan		 	 	x	
m	h		<u>-1998</u>	Japan		 			
sm	7		-2003	Japan Japan					
m	(h = 2001.65		-2001 -2001	Japan				х	
sm,	JP-2001-308165			S (Including Author, Title, I	Date. Pertinent F	Pages, Etc.)			
<u> </u>							-3001136		
hy _		English translation of Abstract for Japenese Patent Application No. JP-4-3001136							
M		English translation of Abstract for Japenese Patent Application No. JP-6-151044							
gn .		English translation of Abstract for Japenese Patent Application No. JP-6-151332							
In .		English translation of Abstract for Japenese Patent Application No. JP-10-189696							
dus		English translation of Abstract for Japenese Patent Application No. 2003-124296							
des	English tran	English translation of Abstract for Japenese Patent Application No. JP-2001-085505							
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OFGS File No. P/2850-79 Application 10/613,574 APPLICANT'S ART CITATION Applicant Takeshi OOTSUKA O(Use several sheets if necessary) **Group Art Unit** Filing Date July 9, 2003 MOD 0 7 2003 U.S. PATENT DOCUMENTS Examiner InteraPAT Filing Date If Appropriate Sub-Date MM-YYYY class Class Name Document Number Maki US-2003/0089687 05-2003 Inazumachi, et al. US-2002/0006678 01-2002 11-1997 Aruga, et al. US-5,688,331 US-US-US-FOREIGN PATENT DOCUMENTS Translation Date MM-YYYY Sub-Country Class **Document Number** class Yes No X 2001-287982 10-2001 Japan X 2003-152064 05-2003 Japan X 7-153706 06-1995 Japan X JP-4-3001136 10-1992 Japan X 05-1994 JP-6-151044 v Japan X JP-6-151332 U 05-1994 Japan X JP-1-0189696 V 07-1998 Japan 2002-124296 04-2002 Japan 03-2001 JP-2001-085505 Japan OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.) English translation of Abstract for Japenese Patent Application No. JP-4-3001136 English translation of Abstract for Japenese Patent Application No. JP-6-151044 English translation of Abstract for Japenese Patent Application No. JP-6-151332 English translation of Abstract for Japenese Patent Application No. JP-1-0189696 English translation of Abstract for Japenese Patent Application No. 2002-124296 English translation of Abstract for Japenese Patent Application No. JP-2001-085505 Examiner Amach Date Considered EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP § 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to the applicant.

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